High-Resolution Terahertz Spectrometer

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Abstract—Terahertz time-domain spectroscopy (THz-TDS) based on high-speed asynchronous optical sampling (ASOPS) with two offset-locked GHz femtosecond lasers requires no mechanical time-delay scanner. Consequently, measurements with 1-GHz frequency resolution are performed at intrinsically high scan rates in the multikilohertz range. This is at least one order, in most cases several orders of magnitude faster than conventional approaches employing mechanical time-delay scanners. We report a system offering a unique combination of high-frequency resolution (1 GHz) and high scan rate (2 kHz) with a spectral coverage of more than 6 THz. Its capabilities for high-precision spectroscopy are demonstrated by measuring the absorption spectrum of a mixture of H₂O, D₂O, and hydrogen deuterium oxide (HDO) vapor. H₂O and HDO vapor absorption spectra are accurately tabulated in databases. However, D₂O absorption data are rare, because of residual H₂O and HDO often present when measuring pure D₂O. Here, we present a high-resolution absorption spectrum of D₂O vapor numerically extracted from the absorption spectrum of the three-component mixture. In addition, we show that the high spectral resolution of the ASOPS THz-TDS system provides benefits in the analysis of frequency-selective surface sensors, which are promising candidates for biosensing applications in the THz regime.

Index Terms—Submillimeter wave spectroscopy, submillimeter wave technology, ultrafast optics, water.

I. INTRODUCTION

TERAHERTZ time-domain spectroscopy (THz-TDS) has emerged as an important tool for a variety of applications in THz science and technology. Prominent examples are drug and food inspection, detection of explosives, label-free DNA analysis, or environmental gas analysis and sensing [1]–[3]. THz-TDS is based on ultrashort laser pulses from a mode-locked laser for the generation of an ultrashort THz pulse and a delayed probe pulse for phase-sensitive detection of the radiation. THz-TDS systems meanwhile cover a large frequency

range from a few tens of GHz into the near-infrared [4]–[7]. One drawback of conventional THz-TDS systems is the use of mechanical delay stages to realize the time delay between the THz pulse and the optical detection pulse. This leads to an inherently low acquisition rate for THz transients. For the analysis of molecular absorption spectra in the gas phase, a high spectral resolution in the 1-GHz range, and thus a time delay of 1 ns is required. To this end, a conventional THz-TDS system needs a mechanical delay stage with a travel distance of 15 cm. The time required for accelerating and decelerating the stage between approximately 100 000 data points and to average out laser noise typically leads to a total acquisition time in the range of a few tens of minutes. Hence, applications, where the acquisition of a THz trace should be completed within a few seconds or even milliseconds, are impossible. Examples for such applications are the fast readout of resonant sensors [8], the observation of conformational dynamics of biomolecules [9], or experiments under rapidly changing external variables, such as spectroscopy in a millisecond pulsed magnetic field [10]. Recently, different systems have been proposed, which operate at higher scan rates, e.g., rotating mirrors with up to 400-Hz scan rate and up to 1 ns time delay [11], [12]. While these systems are advantageous compared to linear stages, drawbacks like noise resulting from masses rotating at >100 000 r/min on the optical table and a scan rate significantly below 1 kHz, where common lasers exhibit the bulk of their amplitude noise, limit their utility. In addition, it should be mentioned that mechanical delay stages are a source of frequency calibration errors due to manufacturing tolerances and limited alignment accuracy.

II. ASYNCHRONOUS OPTICAL SAMPLING

Asynchronous optical sampling (ASOPS) has been introduced with 81-MHz repetition rate picosecond dye lasers in the late 1980s and is a TDS technique that does not require a mechanical delay stage, thus avoiding the potential drawbacks discussed earlier [13]. Our high-speed implementation of ASOPS operates with two femtosecond lasers with repetition rates close to 1 GHz. The repetition rates are stabilized with a constant offset frequency Δf_R in the range of a few kilohertz [14], [15]. As a result of this offset frequency, the time delay between pairs of pulses from the lasers is repetitively ramped between zero and the inverse laser repetition rate (1 ns) at a scan rate equal to Δf_R . Fig. 1 depicts the ASOPS principle for the case that one laser serves as pump for the THz generation, and the other laser is used for electrooptic sampling of the THz transient under the assumption that $\Delta f_R = 10$ kHz. The key advantage of high-speed ASOPS is the scan rate of several kilohertz, which is impossible with mechanical systems. The scan rate allows completing the acquisition of a time-domain trace before technical noise of common femtosecond lasers with significant Fourier

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Fig. 1. Sketch of the ASOPS principle. The pump laser generates the THz pulses (upper row) at a repetition rate of $f_{\text{rep}} + \Delta f_{\text{rep}}$, which are sampled by the probe laser (middle row) with f_{rep} . The bottom row indicates the THz waveform after the mapping through the sample pulse.

content in the acoustic regime up to 1 kHz can affect the signal. Thus, with high-speed ASOPS, measurements at the shot-noise limit are possible without use of lock-in amplifiers or other noise suppression techniques [14].

As depicted in Fig. 2, for the realization of a THz-TDS system, one laser is used to generate the THz radiation, the other laser is used to detect the THz transient in the same geometry as in a conventional THz-TDS setup, e.g., via electrooptic detection [4]–[7]. The THz electric field is mapped onto the polarization of the detection laser beam, which is measured as intensity change in a polarization sensitive detection scheme. These intensity changes are digitized as a function of real time t and recalibrated to a time-delay scale τ , using a factor $\Delta f_R / f_R$, where f_R is the repetition rate of the THz generation laser.

In the last three years, the performance of our high-speed ASOPS THz-TDS spectroscopy approach has improved significantly [14]–[16]. While the first implementation had a spectral coverage of 0.5 THz, the latest implementation of the high-speed ASOPS THz spectrometer achieves a spectral coverage of more than 6.5 THz, corresponding to a time resolution of better than 50 fs and a spectral resolution of 1 GHz.

III. THz SPECTROMETER

The THz-TDS system is sketched in Fig. 2. Core elements are two 1-GHz repetition rate Ti:sapphire lasers sharing a common housing milled from a solid aluminum block that are operated in a master–slave configuration. The repetition rate of the master laser is free running and the slave laser repetition rate is stabilized with an offset Δf , using a phase-locked loop. A repetition rate difference Δf of 2 kHz in combination with the 1-GHz repetition rate and the 100 MHz bandwidth of the photodetector and the analog-to-digital (A/D) converter yields a data point spacing of 20 fs, which is sufficient to support the 45-fs time resolution as given by the duration of the laser pulses [17].

Both lasers deliver about 800 mW of average output power at center wavelengths of 825 nm and have a pulse duration of ≈ 45 fs. A small portion of the output power of each laser is split

off with beamsplitters and is focused onto 10-GHz bandwidth photodiodes in order to detect the repetition rates and their harmonics. The photodiode signals are used to phase-coherently generate an error signal, representing deviations of the repetition rate-offset Δf from the desired value Δf_{set} . The error signal is amplified and low-pass filtered with a loop filter and further amplified by use of a high-voltage amplifier to control the slave repetition rate. This is accomplished via a weight-reduced cavity mirror mounted onto a high-bandwidth piezoelectric transducer for adjusting the cavity length of the slave laser. Details of the offset stabilization have been outlined previously [17]. The A/D converter is triggered by a cross-correlation signal between master and slave laser generated via two-photon absorption in a GaP photodiode, using split-off beams from both lasers with 100-mW average power.

Fig. 3(a) shows the first 40 ps of a 1-ns-long THz transient. The presented data were acquired in 9 min and the spectrometer was purged with dry air. The main THz pulse is generated by an optical pump pulse of 45 fs duration and 55- μm spot size (full-width at half maximum) with an average power of 550 mW on a large area photoconductive THz emitter. The emitter is dc-biased with 10 V, which corresponds to an electric field of 20 kV/cm for the acceleration of carriers in the GaAs substrate. Details of the emitter are described elsewhere [18]. Internal reflections of the main THz pulse in the 400- μm -thick GaP detector crystal and in the 645- μm -thick GaAs emitter substrate lead to satellite signals at 9 and 16 ps and combinations of these values at later time delays, respectively. The satellites do not influence absorption measurements, because they are equally present in the reference measurement and in the sample measurement and thus divide out in the Fourier domain. Fig. 3(b) shows the corresponding numerical Fourier transform of the full time-domain data. The high-frequency modulation on the spectrum stems from the multiple reflections of the main THz pulse in the time domain. The spectral coverage above the noise floor ranges from 0.2 to 6.5 THz. Fast oscillations present on the signal after the main THz pulse [see Fig. 3(a) inset] arise from the reduced propagation velocity of phonon-polaritons in the GaAs emitter substrate at frequencies close to the transverse-optical (TO) phonon [15], [19], [20].

The limitation of the spectrometer bandwidth to less than 7 THz originates from the nonlinear response function of the GaP detection crystal used for electrooptic detection via the Pockels effect. In the THz frequency range, an electronic part as well as an ionic part contributes to the second-order susceptibility χ^2 . The ratio between both parts is described by the Faust–Henry coefficient [21]. For many semiconductors, such as GaP, the Faust–Henry coefficient is negative. This expresses that both contributions subtract from each other for frequencies below the TO phonon frequency. In the case of GaP, the electronic and ionic part cancel out in the frequency range around 7 THz [19], [21], [22]. While the response of GaP recovers beyond the minimum around 7 THz, the spectral coverage of the spectrometer is still limited to frequencies below 8 THz. This is due to the TO phonon of the GaAs emitter substrate, which could be circumvented by either using the emitter in reflection geometry or by thinning down the emitter substrate [23].

Fig. 2. Setup of the high-speed ASOPS THz spectrometer.

Fig. 3. (a) THz transient with multiple reflections of the THz pulse in the THz emitter substrate and in the GaP detection crystal. The inset shows a zoom-in into the first picoseconds after the main THz pulse. The high-frequency components stem from the phonon-polariton propagation in the emitter substrate. (b) Corresponding Fourier transform of the THz transient shown in (a) on a logarithmic scale.

Beyond 8 THz, the 45-fs pulse duration of the 1 GHz Ti:sapphire laser are the limiting factor.

IV. SYSTEM ACCURACY

The frequency accuracy of a THz spectrometer based on a THz-TDS system is determined by the accuracy of the time-delay scale τ . For a conventional THz-TDS system, the frequency accuracy is entirely given by the calibration and alignment of the delay stage. For a system based on high-speed ASOPS, the time delay is given as $\tau = t \times \Delta f_R / f_R$, and its accuracy is thus determined by that of the spectrum analyzer or frequency counter used to measure the repetition rates and the system clock of the A/D converter that defines the real-time scale t . The accuracy of these instruments can be as good as that of a cesium atomic clock (10^{-15}) or a more readily available commercial GPS-referenced Rubidium reference (10^{-12}). However, in the ASOPS THz-TDS spectrometer described here

a lower cost oven stabilized crystal oscillator is used with a relative frequency uncertainty of approximately 10^{-7} . Another potential factor, which might influence the accuracy of a high-speed ASOPS system, are deviations of the true $\Delta f_R / f_R$ value from the nominal value that occur during a measurement cycle [17]. These deviations may be in phase with the trigger signal, i.e., they repeat for each measurement, such that they do not average out. Modulations of Δf_R due to imperfections in the offset-locking electronics can cause such systematic deviations. In a cross-correlation measurement, the mean relative deviation of $\Delta f_R / f_R$ from the nominal value was determined to 9.8×10^{-5} , the associated maximum relative uncertainty of the frequency calibration is 1.7×10^{-4} [17].

V. ATMOSPHERIC WATER VAPOR (H_2O)

One of the most suited samples to test the spectral accuracy of a THz-TDS system is atmospheric water vapor [24]. Between

Fig. 4. Measured (black) and calculated (red) absorption spectra of atmospheric water vapor acquired in (top) 60 s and (bottom) 0.6 s. The calculated spectrum is based on the HITRAN database.

0.2–6.5 THz more than 1000 absorption lines exist, which are well known from experimental investigations and theoretical calculations. These lines are documented in the HITRAN and JPL databases [25]–[27]. For the HITRAN database of water vapor data, the reported frequency error is between 300 kHz and 3 MHz. Hence, it is possible to test the THz spectrometer at this accuracy level. At atmospheric conditions, the width of each absorption line lies in the range of 10 GHz, which is well matched to the 1 GHz resolution of the THz spectrometer determined by the 1 ns observation window. At the top of Fig. 4, the comparison between a measured and calculated water vapor absorption spectrum is plotted. The acquisition time for the transient with water vapor was 60 s, the reference data are the data averaged over 9 min, as shown in Fig. 3. At this point, we emphasize that a long reference measurement does not affect the high-speed capability of the system, but rather helps improving the quality of subsequently acquired absorption data calculated from traces with much shorter acquisition times (e.g., 0.6 s, see later on and Fig. 4). The calculated spectrum is based on data from the latest version of the HITRAN database [27]. The formulas for the calculation of the full-spectral lineshapes can be found in reference [26]. During the 60 s measurement,

the ambient parameters were kept constant (temperature 20 °C, pressure 1015 hPa, relative humidity 26%).

From 0.2 to 2.5 THz, the measured and calculated absorption spectra agree very well quantitatively in frequency and amplitude. Above 2.5 THz, the reduced dynamics range of the spectrometer lead to deviations in the measured absorption strength. Absorption lines, which exceed 0.15 cm⁻¹ cannot be fully resolved (see Fig. 5). However, the frequency of each absorption line can still be evaluated with high precision. To analyze the water vapor absorption data in more detail, all measured absorption lines from 0.2 to 6.5 THz were fitted with a Lorentzian lineshape given by

$$\alpha(\nu) = S\rho \frac{1}{\pi} \frac{\gamma}{\gamma^2 + (\nu - \nu_0)^2} \quad (1)$$

where α is the absorption coefficient in cm⁻¹, ν is the wavenumber in cm⁻¹, S is the line intensity in cm⁻¹/(molecule·cm⁻²), ρ is the number of H₂O molecules per cm³, γ is the pressure-dependent half-width half maximum (HWHM) in cm⁻¹, and ν_0 is the pressure corrected line position in cm⁻¹. For more details, see [26]. An automatic numerical routine analyzes the experimental data: The routine extracts all line positions and performs

Fig. 5. Detailed view of the absorption spectra around 5 THz. The noisy part of the experimental data is deleted when performing the fits.

a Lorentzian lineshape fit for every absorption line. For lines with a frequency greater than 2.5 THz and absorption strength greater than 0.15 cm^{-1} , the shape is not fully resolved. Hence, the noisy center part of these absorption lines is removed, and the fit is based on the wings of the lines.

In the range from 0.2 to 6.5 THz, 147 lines can be found in the HITRAN database with intensities larger than $3 \times 10^{-21} \text{ cm}^{-1}/(\text{molecule} \cdot \text{cm}^{-2})$. This intensity gives the lower detection limit of the THz spectrometer in the range from 0.2 to 6.5 THz. Eighty-seven lines are evaluated by the mentioned numerical routine. The remaining 60 lines are either too close to a neighboring line and hence lead to a nonconverging fit or their intensity is too weak to be detected numerically. The mean deviation of the line positions ν_0 from the HITRAN data over all fitted lines is 142 MHz. The mean relative deviation is 5.7×10^{-5} . The largest deviation of any line is 461 MHz, corresponding to a relative deviation of 2.5×10^{-4} . These errors are consistent with the earlier estimated effect of a systematic calibration uncertainty of the time-delay versus real-time scale due to imperfections in the locking electronics. The errors of our measurements of temperature ($\pm 1 \text{ K}$), pressure ($\pm 5 \text{ hPa}$), and humidity ($\pm 2\%$ relative humidity) cause only a negligible uncertainty (maximum $\pm 1.5 \text{ MHz}$) in the calculation from the HITRAN database and are not significant in the evaluation of the frequency error.

The averaged relative deviation of the line intensity S from the calculated spectrum based on the HITRAN data is 6.0% for the fully resolved lines below 2.5 THz and increases to 12.3% when all evaluated lines are considered. This is consistent with the 6% uncertainty in the calculated line intensity due to the mentioned errors of temperature, pressure, and humidity and additional errors expected from the limited dynamic range of the spectrometer above 2.5 THz.

We have repeated the same evaluation for data acquired with 0.6 s acquisition time, as shown in the bottom panel of Fig. 4. The mean and maximum deviations from the HITRAN database increase only slightly to 164 and 468 MHz, respectively. While these values are similar to the data at 60-s acquisition time, the available spectral coverage was obviously reduced to 3.5 THz due to a reduced SNR above this value.

VI. HEAVY WATER VAPOR (D_2O)

The natural concentration of $^1\text{H}_2^{16}\text{O}$ water molecules compared to all other isotopes of water is 99.73% [28]. D_2O absorption data are rare due to the difficulty in establishing experimental conditions for measuring pure D_2O vapor, since it is hardly possible to remove H_2O molecules completely from the sample volume and maintain pure D_2O vapor in the cell [29], [30].

The replacement of H_2O vapor with D_2O vapor is very difficult. One possibility is to evacuate the sample volume and subsequently insert liquid D_2O , which immediately evaporates. A problem of this method is the immediate contamination of D_2O molecules with H_2O molecules that are left adherent to the chamber walls. These H_2O molecules interchange with the inserted D_2O due to similar partial vapor pressures. Also, the two water species interchange H and D atoms very rapidly, and the third water species hydrogen deuterium oxide (HDO) is formed [31].

The HITRAN database only contains data for H_2O - and HDO-vapor, but there are no data available for D_2O [27]. An additional source for water vapor data is the JPL database [25]. From the HITRAN database, it is possible to reconstruct the full experimental absorption spectrum for H_2O and HDO (see Figs. 4 and 5), but the JPL database only contains the line positions and the integrated intensities. From these data, it is not possible to reconstruct a full absorption spectrum due to missing lineshape data, i.e., the HWHM at a given pressure and temperature of each line.

Hence, Fig. 6 compares only the line positions of H_2O , HDO, and D_2O from the JPL database with the experimental absorption spectrum. From the experimental water vapor mixture data, it is possible to calculate a D_2O absorption spectrum by subtracting calculated absorption spectra of H_2O and HDO based on the full information of the HITRAN database. The best suppression of H_2O and HDO lines is achieved for an assumed H_2O humidity of 1.4% and a HDO humidity of 4.5%. The optimal humidity values are found by iteratively varying these values and subsequent subtraction of the calculated spectrum from the experimental one, until the best result of H_2O and HDO line suppression is achieved (see Fig. 7). The high accuracy of the ASOPS system with respect to frequency and amplitude enables this simple procedure without further data processing. From Fig. 7, it is obvious that negative absorption peaks result for some removed H_2O and HDO lines. These residual errors are most pronounced in the vicinity of strong H_2O lines and strong HDO lines and are caused by our remaining uncertainty in the partial humidity values. It should be pointed out that the HITRAN database contains the absorption data of atmospheric water vapor with a natural HDO concentration of 0.031%. Thus, the HDO part of the calculated absorption spectrum must be multiplied by ~ 3200 to obtain results for pure HDO vapor.

From the H_2O and HDO concentration, it is possible to calculate the D_2O concentration. By setting up the rate equation for the generation and elimination of one water species, the concentration of D_2O is given by $n_{\text{D}_2\text{O}} = n_{\text{HDO}}^2 / 4n_{\text{H}_2\text{O}}$. For the humidity values H_2O and HDO (1.4% and 4.5% humidity, respectively), this yields a D_2O humidity of 3.6%. Hence, the ratio of H_2O :HDO: D_2O is about 1:3.2:2.5.

Fig. 6. Detailed absorption spectrum of the experimental water vapor mixture from 0.5 to 4.5 THz. Each column covers 1 THz. The line positions of H₂O, HDO and D₂O are indicated by squares, circles, and triangles respectively and taken from the JPL database [25].

Fig. 7. Detailed absorption spectrum of D₂O calculated from the experimental data of Fig. 6 by subtracting calculated spectra of H₂O and HDO. Again the triangles indicate the line positions of D₂O.

Fig. 8. Lateral unit cell structure of the FSS. The resonators are dimensioned with $w = 10 \mu\text{m}$, $\phi = 22^\circ$, $d\phi = 5^\circ$, $p = 197 \mu\text{m}$, and $r = 49 \mu\text{m}$. (b) Transmission characteristic of the FSS.

VII. FREQUENCY-SELECTIVE SURFACES

Apart from high-precision gas-phase spectroscopy, another important application of high-speed and high-resolution THz spectrometer is the rapid and precise readout of characteristic resonances of frequency-selective surface (FSS) sensors in the THz range. Such devices are based on metallic resonator arrays with tailored transmittance and reflectivity properties [32]. In numerical simulations, it has been proposed to use THz-FSS based on asymmetric split ring resonators as sensor for detecting biomolecular sample films with a thickness of only 10 nm [33]. Applying substances to an FSS changes the resonant response of the sensor array, which can be monitored in transmittance or reflectivity [34]–[36]. In case of asymmetric split ring resonators, there is an extraordinary strong field enhancement in the gap region of the ring resonator [37]. Compared to classic free-space radiation analysis [38], [39], this field localization leads to a much higher sensitivity of THz-FSS-based sensing reducing the required amount of sample material significantly. For diagnostic applications, however, up to 100 arrayed gene sensors need to be read out in a reasonably short time. Up to now, broad-band sensor readout has been done with rather slow operating conventional THz time-domain spectrometers based on mechanical delay stages [24]. Thus, we investigated the capability of our high-speed ASOPS spectrometer to precisely determine the resonance of a THz-FSS in a short measurement time.

The THz-FSS consists of asymmetric double-split metallic rings arranged on a quadratic grid with a pitch of $p = 197 \mu\text{m}$. A unit cell of the array is shown in Fig. 8(a). The rings are placed on top of a $27\text{-}\mu\text{m}$ -thick polymer substrate made of benzocyclobutene (BCB) with an assumed permittivity $\epsilon_r = 2.6$ and dielectric loss factor $\tan \delta = 0.0001$. The FSS is fabricated by spin-on deposition of the BCB layer on a silicon host substrate, including thermal curing at 210°C for 2 h. The ring structures are patterned on top of the BCB, using a standard photolithography process, e-beam metal evaporation (Cr/Au with 10-nm/200-nm thickness) and photoresist liftoff. In a last step, the FSS is lifted off the silicon substrate in KOH solution.

The transmission spectrum of the FSS array is measured with the polarization of the THz radiation perpendicular to the mirror axis of the FSS in order to excite the highest extinction funda-

Fig. 9. Fit parameter x_c plotted versus measurement time. The inset shows the experimental data (black squares) and the fit function (red solid line).

mental resonance of the FSS [see Fig. 8(b)]. The resonator array is equipped with an element perturbation such that every arc pair provides two slightly different resonant frequencies. Consequentially, the transmission spectrum exhibits the expected devolution with a local transmission maximum in-between a narrow and a broad absorption line generated by modal-interaction as described by Larson and Munk [40]. The local transmission maximum appears when the array self-reactance X_A becomes equal to the sum mutual reactance X_M . In this case, the currents are excited in antiphase. The scattered electromagnetic fields interfere destructively, so the coupling to free space is strongly reduced. Fedotov *et al.* denote this as a “trapped mode” [41]. For sensing applications, this mode is extremely attractive since it offers strong field localization and temporal remaining energy storage at the resonator surface where thin films of sample material shall be detected.

In order to evaluate the frequency position of the modal-interaction resonance, a function based on two modified sigmoid functions is fitted to the first minimum [see ellipse in Fig. 8(b) and Fig. 9 (inset)]. The function contains five fit parameters

$$f(x) = y_0 + A \left(\frac{1}{1 + \exp\left(-\frac{x-x_c}{w_1}\right)} \right) \times \left(1 - \frac{1}{1 + \exp\left(-\frac{x-x_c}{w_2}\right)} \right) \quad (2)$$

y_0 is the offset, A is the Amplitude, w_1 is the falling edge, w_2 is the rising edge, and x_c describes the position of the resonance [see Fig. 9 (inset)]. Since the fit function is transcendental, the function and its derivatives cannot be analytically solved for x_c . However, it can be shown that x_c must be located between the minimum and the second inflection point. The fit ranges from 0.608–0.673 THz and consists of 55 data points. To test the relation between frequency uncertainty and measurement time, we performed ten individual measurements for different acquisition times ranging from 0.1–2.1 s. In total, 200 spectra were

fitted. For every fit the parameter x_c converges against a fixed value without adjusting the other fit parameters. Fig. 9 shows the fit parameter x_c versus measurement time. The scatter of the x_c values decreases with measurement time and remains within a 329-MHz band at 1.9 s or greater. The standard deviation of the acquired data points at 2.1 s is 108 MHz. The statistical fitting error for x_c for each individual measurement is about 180 MHz. The combination of the standard deviation of x_c at 2.1 s and the statistical fitting error leads to a mean value of $x_c = 0.66113 \text{ THz} \pm 210 \text{ MHz}$ within a read-out time of 2.1 s. This result should prove to be highly beneficial for fast sensing of small amounts of biomaterials on a THz-FSS sensor array.

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